

Multi-GeV Multi-Ring Systematics

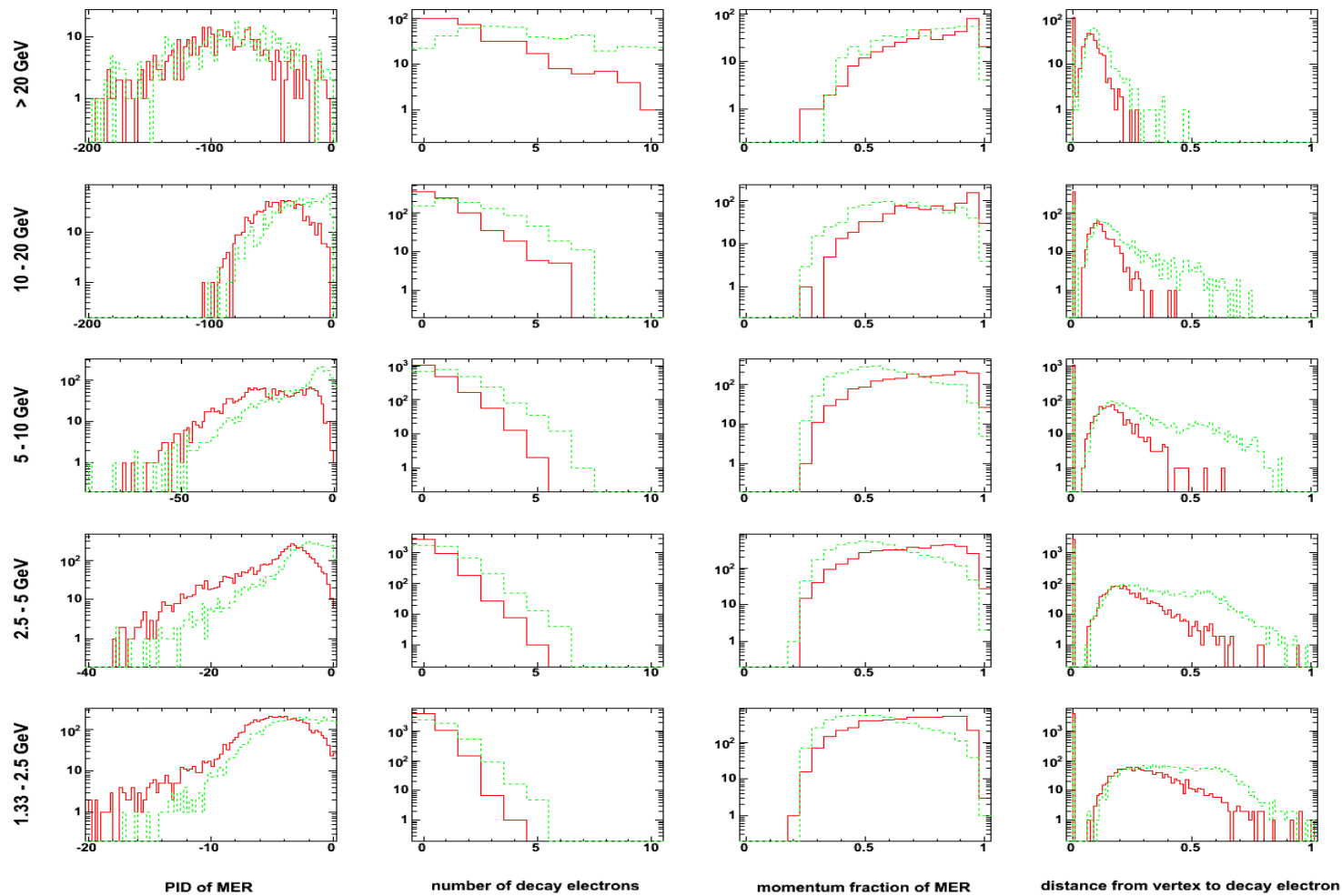
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20090424

Oscillations Working Group

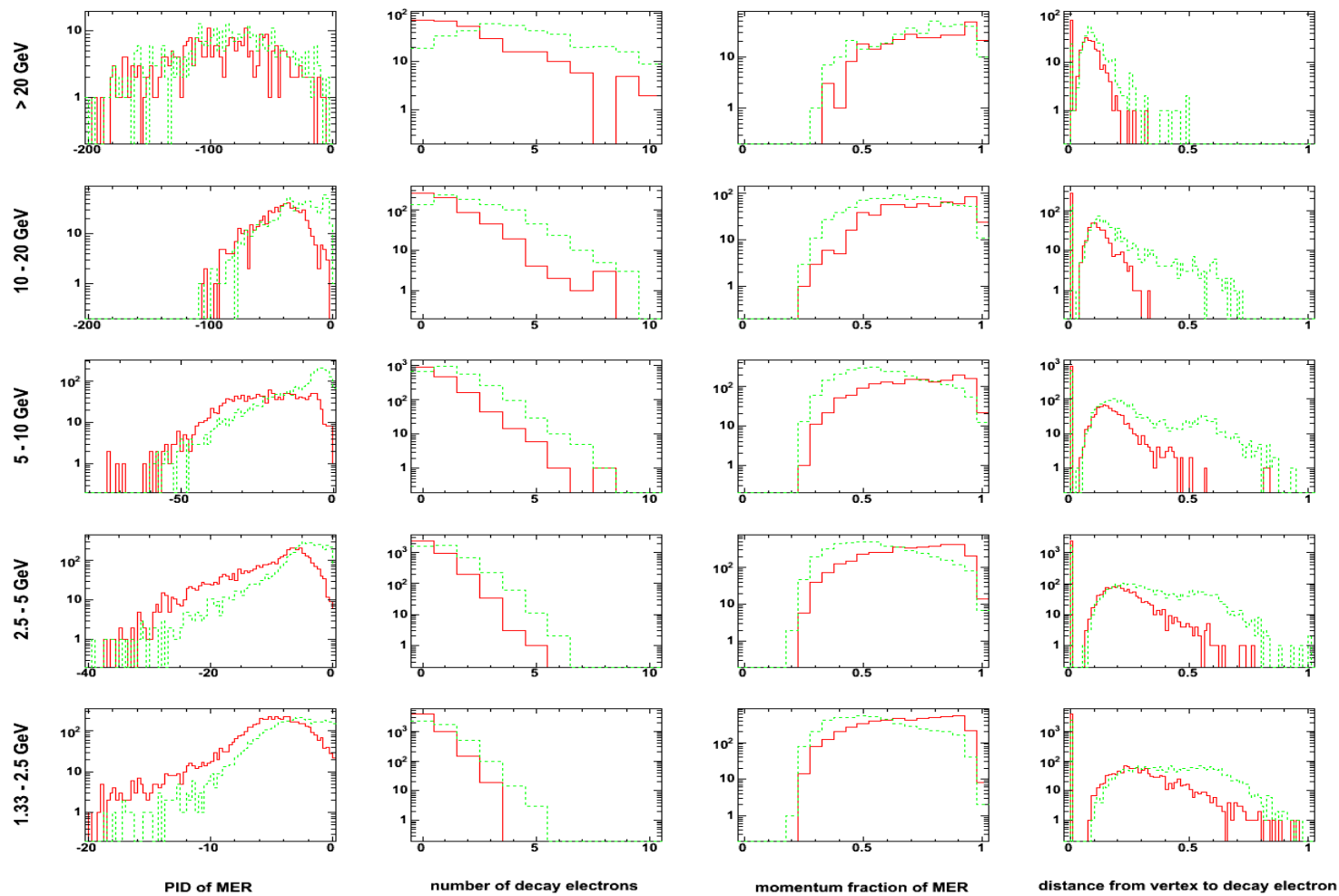
- **BG contamination, Likelihood systematic**

Multi-Ring Multi-GeV e-like likelihood: 100 yr SK-I



— Signal (CC ν_e)
— Background (CC ν_μ , NC)

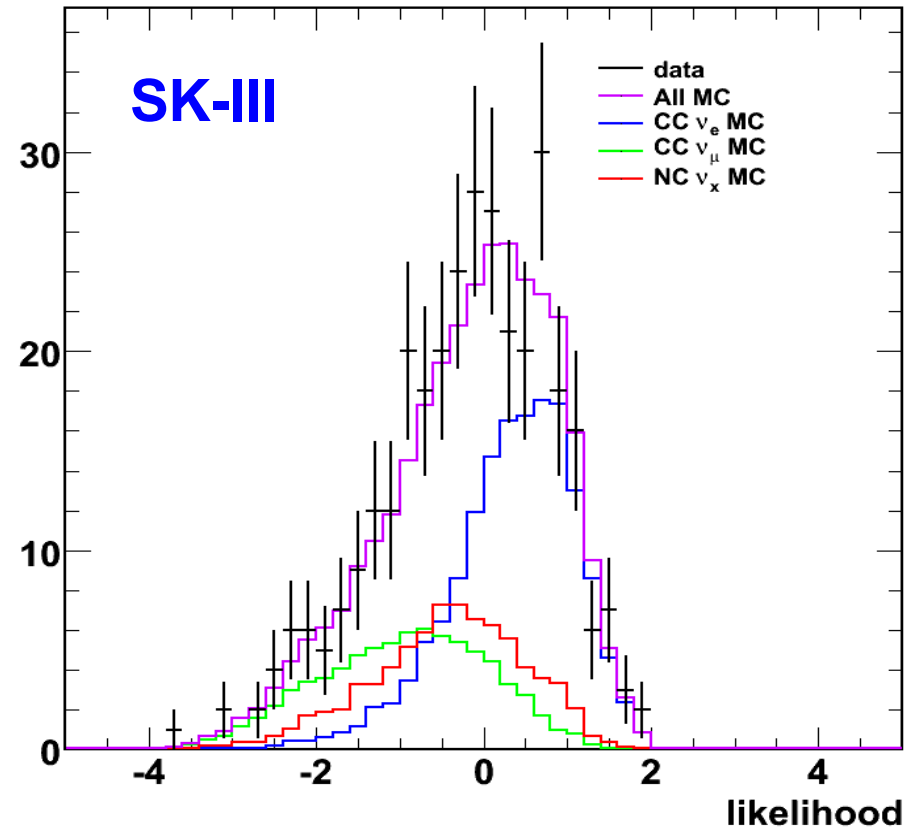
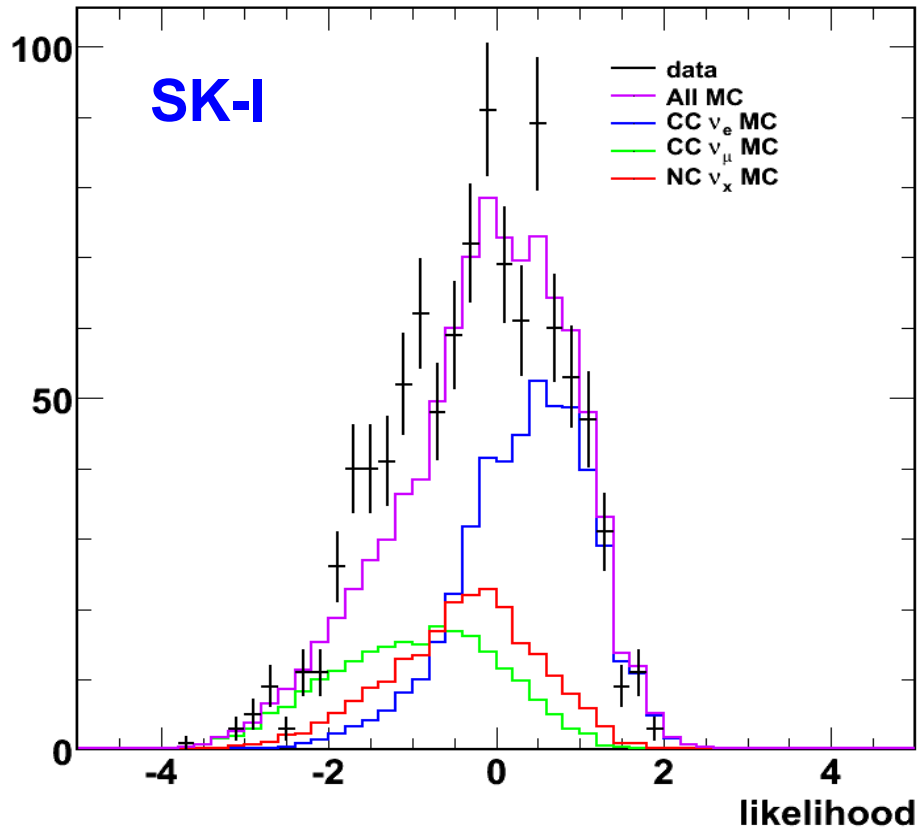
Multi-Ring Multi-GeV e-like likelihood: 100 yr SK-III



— Signal (CC ν_e)
— Background (CC ν_μ , NC)

- Shapes are consistent with SK-I (II)

Total Likelihood Distribution

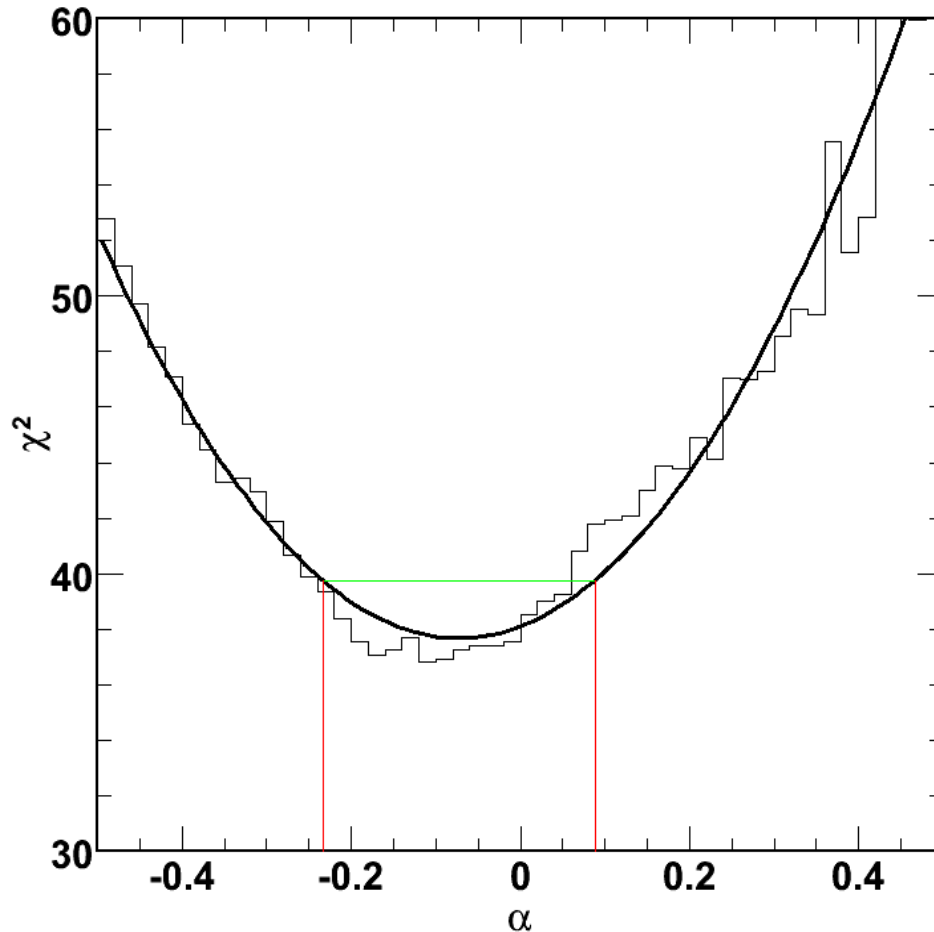


	CC ν_e	CC ν_μ	NC	Total
raw	46.4%	31.5%	22.0%	100%
Likelihood	71.3%	12.7%	16.0%	100%

SK-I CC ν_e : 74.4%

SK-II CC ν_e : 72.9%

Systematic Error Estimation



- Fit likelihood distribution of the data for different shifts of the MC signal BG distribution

fitting function:

$$f_{\nu_{eCC}}(x; \alpha) + f_{\text{NC}}(x, \beta) + f_{\nu_{\mu CC}}(x, \beta)$$

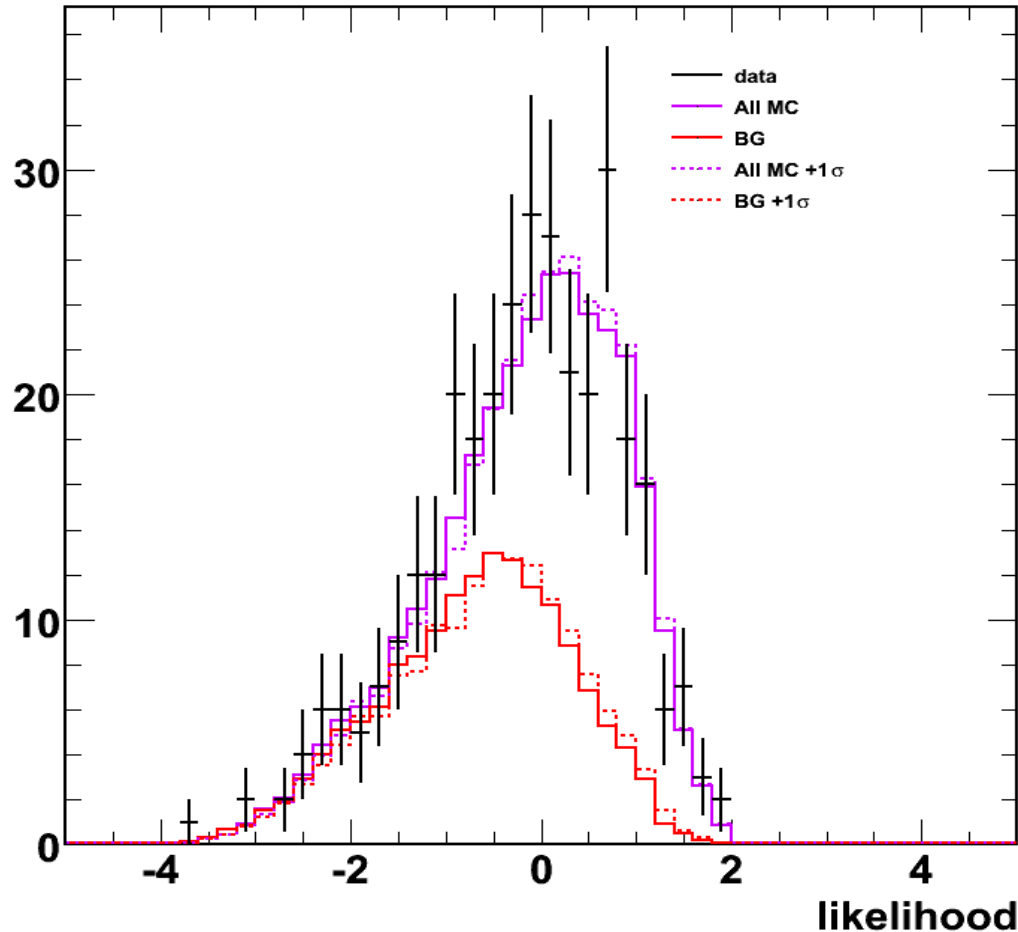
α, β : shift in Likelihood parameter

find best-fit by χ^2 and derived α at 1σ upper limit.

- Uncertainty becomes the percent change in amount of signal (background) background corresponding to the $1\text{-}\sigma$ shift in the parameter α (β)

Non ν_e Background Systematic

SK-I :



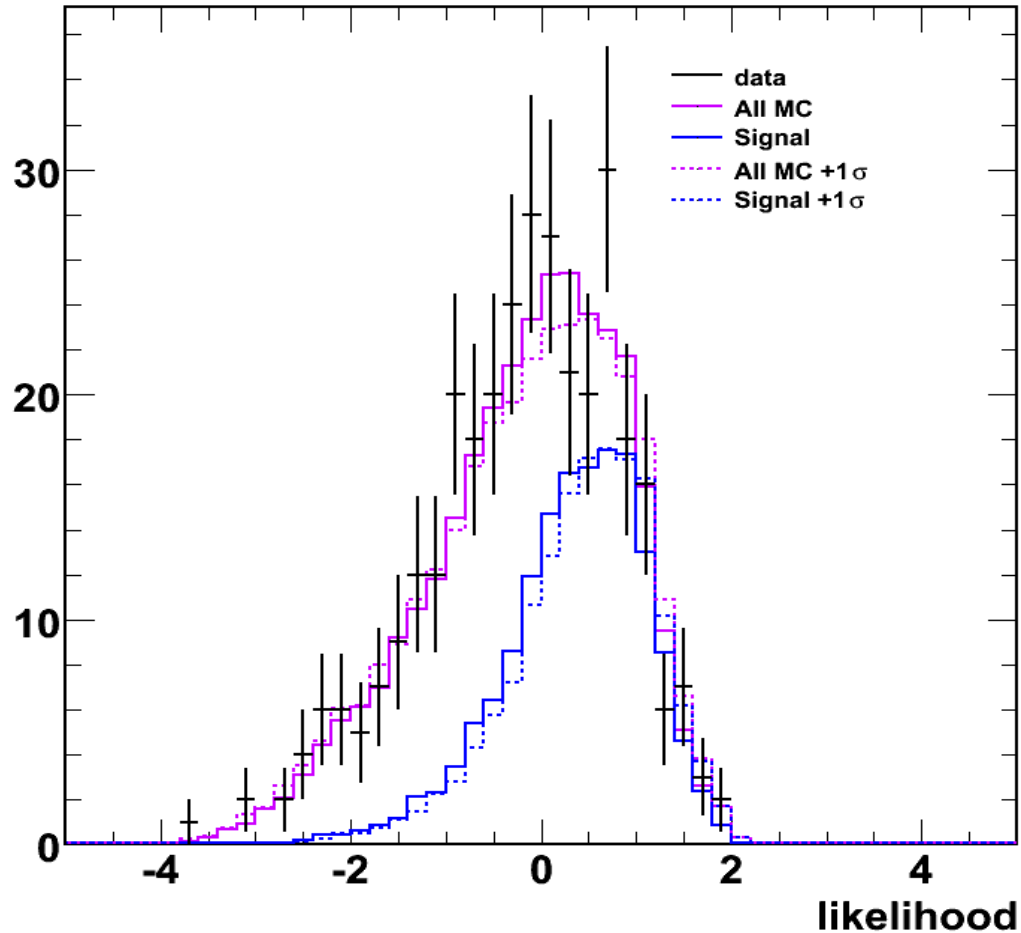
	All	BG	
standard	453.9	118.7	
Fitted	420.2	88.7	
+ 1 σ	441.2	109.8	-7.5%
- 1 σ	407.9	76.4	-35.6%

SK-III :

	All	BG	
Raw MC	152.9	40.6	
Fitted	147.2	33.3	
Fitted +1 s	154.0	44.7	+10.1%
Fitted -1 s	142.0	27.6	-32.0%

- Systematic error is taken to be the larger : **32.0%**

Multi-Ring Multi-GeV Likelihood Systematic



SK-I :

	All	Signal	
standard	453.9	335.3	
Fitted	420.2	331.4	
+ 1s	423.1	334.3	-0.3%
- 1s	402.6	313.8	-6.4%

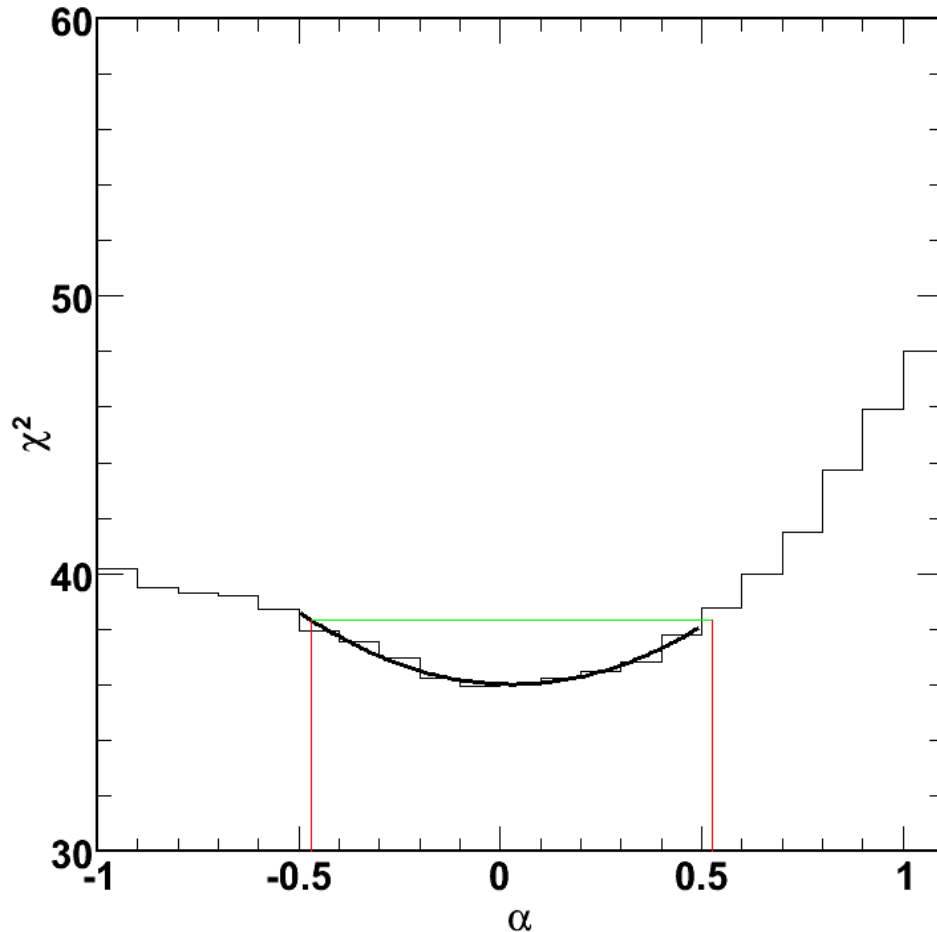
SK-III :

	All	Signal	
Raw MC	152.9	112.3	
Fitted	147.2	112.0	
Fitted +1 s	154.0	118.8	+5.7%
Fitted -1 s	142.0	106.8	-4.9%

- Systematic error is taken to be the larger : **5.7%**

Systematic Error Estimation: Single Ring e-like

Systematic Error Estimation : Singe-Ring e-like



- Fit likelihood distribution of the data for different shifts of the MC signal BG distribution

fitting function:

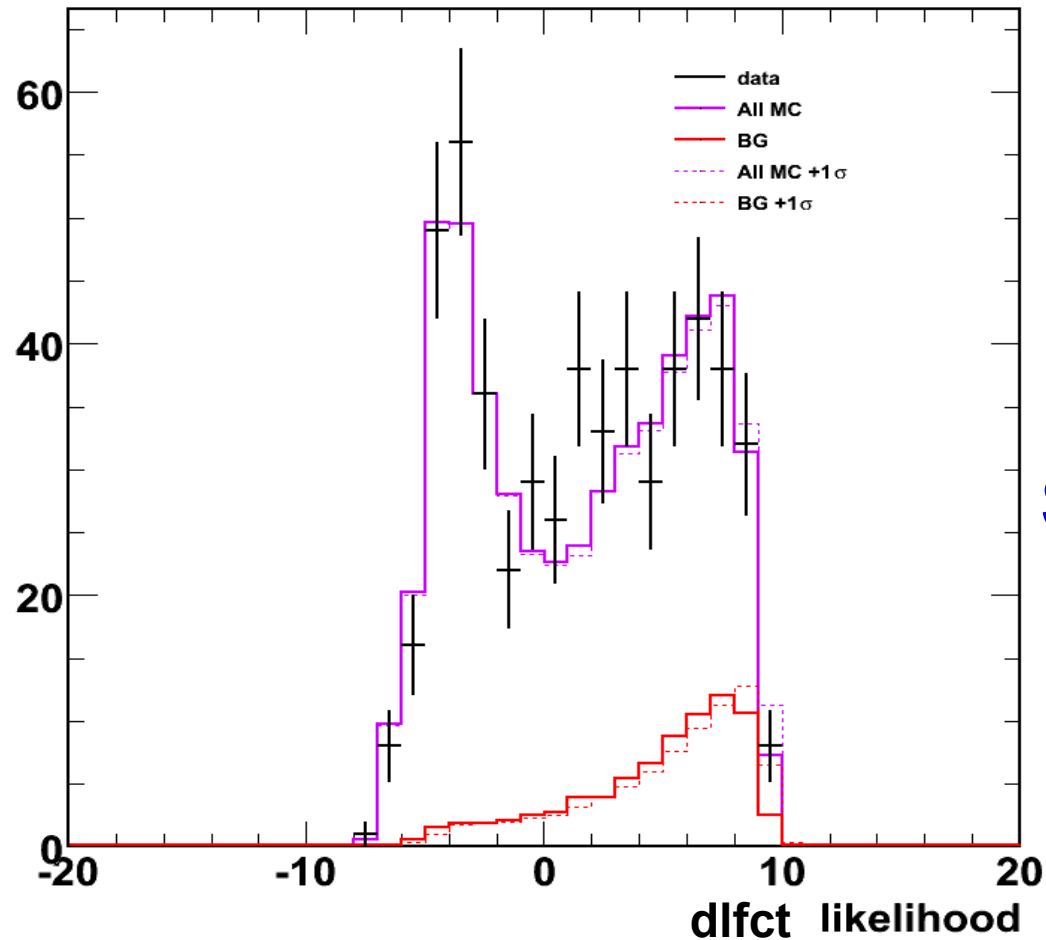
$$f_{\nu_{eCC}}(x; \alpha) + f_{\text{NC}}(x, \beta) + f_{\nu_{\mu CC}}(x, \beta)$$

α, β : shift in Likelihood parameter

find best-fit by χ^2 and derived α at 1σ upper limit.

- Much more shallow for single-ring case
 - Non- χ^2 shape

Non ν_e Background Systematic : Single ring e-like



SK-I :

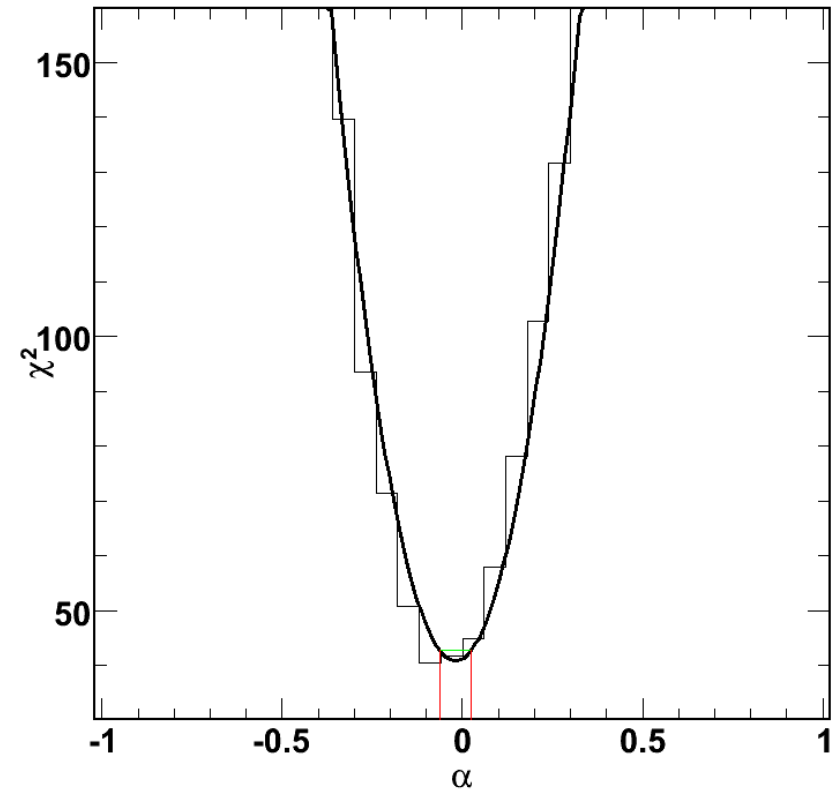
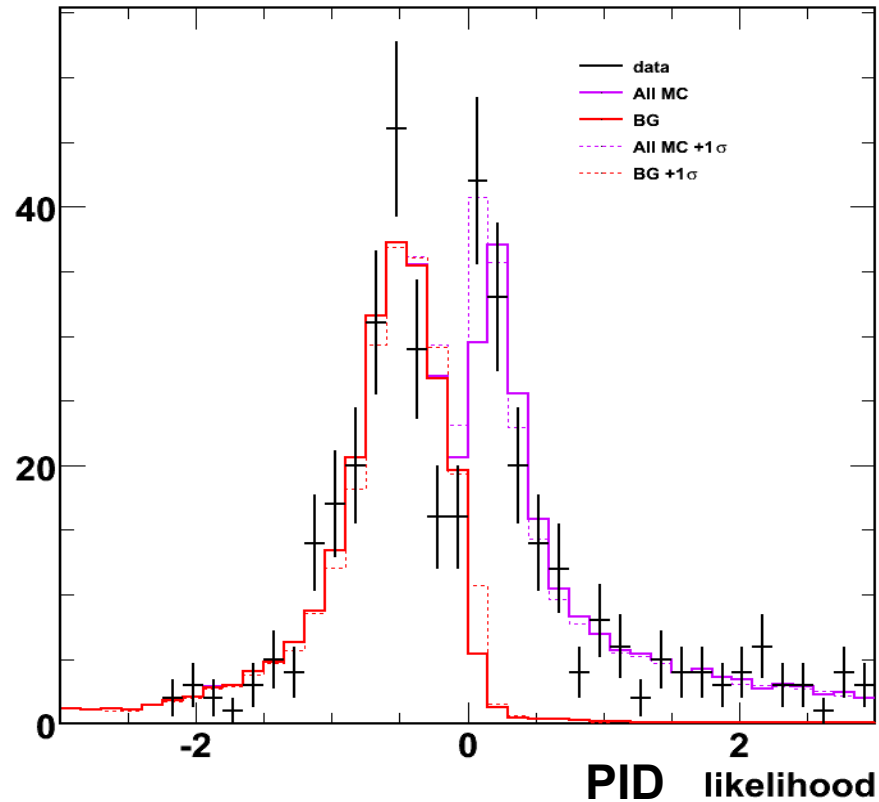
• 14.5%

SK-III :

	All	BG	
Raw MC	2647	12.67	
Fitted	264.8	12.7	
Fitted +1 s	263.4	11.4	-10.55
Fitted -1 s	265.9	13.9	-9.3%

• Systematic error is taken to be the larger : 10.6%

Use PID instead ?



$$+ : 15.6 / 9.9 = 58.0\%$$

$$- : 5.8 / 9.9 = -41.5\%$$

- Systematic error would be the larger : **58.0%**

Summary

- **Multi-ring Multi-GeV e-like Systematic Errors:**
 - Non ν_e contamination - 32.0 %
 - Likelihood systematic - 5.7 %
- **Single-ring Multi-GeV e-like Systematic Error:**
 - Non ν_e contamination - 10.6 %
 - Requires more investigation

all BG(muCC+NC) eCC BG/all
normal : 152.912 40.5801 112.332 0.265382
fitted : 145.273 33.2739 111.999 0.229044
fitted+1sig : 156.692 44.6929 111.999 0.285228
fitted-1sig : 139.973 27.5997 112.373 0.197179
bg systematic (fitted - normal/normal) : $33.2739-40.5801 / 40.5801 = -0.180044$
bg systematic (fit+1s - normal/normal) : $44.6929-40.5801 / 40.5801 = 0.10135$
bg systematic (fit-1s - normal/normal) : $27.5997-40.5801 / 40.5801 = -0.319871$

all BG(muCC+NC) eCC signal/all
normal : 152.894 40.5754 112.319 0.73462
fitted : 147.23 35.2448 111.986 0.760619
fitted+1sig : 153.998 35.2448 118.753 0.771133
fitted-1sig : 142.038 35.2448 106.793 0.751862
sig systematic (fitted - normal/normal) : $111.986-112.319 / 112.319 = -0.00296477$
sig systematic (fit+1s - normal/normal) : $118.753-112.319 / 112.319 = 0.0572833$
sig systematic (fit-1s - normal/normal) : $106.793-112.319 / 112.319 = -0.0491992$

before likelihood cut (all energy)

nue CC, numu CC, NC, total = 11007 7474 5218 23699

46.445% 31.5372% 22.0178%

after likelihood cut (all energy)

nue CC, numu CC, NC, total = 7915 1407 1775 11097

71.3256% 12.6791% 15.9953%

efficiency= 71.9088%